

Sheet 1 of 1		INFORMATION DISCLOSURE STATEMENT						
FORM PTO 1449 (modified) U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE LIST OF REFERENCES CITED BY APPLICANT(S) <i>(Use several sheets if necessary)</i> Date Submitted to PTO: April 18, 2005				ATTY DOCKET NO. 2003_1592A		SERIAL NO. 10/716,115		
				APPLICANT Munenori FUJIMURA et al.				
				FILING DATE November 19, 2003		GROUP 2821		
U.S. PATENT DOCUMENTS								
*EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE	
T.D	AA	6,163,300	12/2000	Ishikawa et al.	343	702	/	
	AB	6,486,853	11/2002	Yoshinamoto et al.	343	895		
	AC	6,452,548	9/2002	Nagumo et al.	343	700 MS		
T.D	AD	6,862,003	3/2005	Yoshinamoto et al.	343	895		
	AE							
	AF							
	AG							
FOREIGN PATENT DOCUMENTS								
		DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION YES NO	
T.D	AH	11-284427	10/1999	JP	1			
	AI	2002-217629	8/2002	JP				
	AJ	2001-217643	8/2001	JP				
	AK	10-313209	11/1998	JP			Abstract	
	AL	09-238018	9/1997	JP			Abstract	
	AM	2000-183634	6/2000	JP			Abstract	
✓	AN	07-066616	3/1995	JP			Abstract	
OTHER DOCUMENT(S) (Including Author, Title, Date, Pertinent Pages, Etc.)								
	AO							
	AP							
	AQ							
EXAMINER				Trinh Vo Dinh DATE CONSIDERED 05/26/05				

*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

FORM PTO 1449 (modified)

U.S. DEPARTMENT OF COMMERCE
PATENT AND TRADEMARK OFFICEATTY DOCKET NO.
2003-1592ASERIAL NO.
10/716,115LIST OF REFERENCES CITED BY APPLICANT(S)
(Use several sheets if necessary)APPLICANT
Yunenori FUJIMURA et al.

Date Submitted to PTO: June 15, 2004

FILING DATE
November 19, 2003GROUP
2821

U.S. PATENT DOCUMENTS

*EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
T.D	AA	2002/0118142 A1	08/29/02	Wang	343	895	/
T.D	AB	6,404,394 B1	06/11/02	Hill	343	702	/
	AC						
	AD						
	AE						
	AF						
	AG						
	AH						
	AI						

FOREIGN PATENT DOCUMENTS

		DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION YES NO	
T.D	AJ	0 831 546 A2	03/25/98	EP	—	—	yes	
	AK							
	AL							
	AM							
	AN							

OTHER DOCUMENT(S) (Including Author, Title, Date, Pertinent Pages, Etc.)

	AO	
	AP	
	AQ	

EXAMINER

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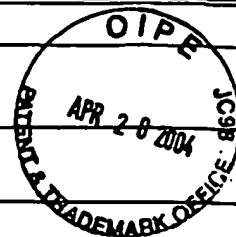
DATE CONSIDERED

05/26/05

FORM PTO 1449 (modified)

U.S. DEPARTMENT OF COMMERCE
PATENT AND TRADEMARK OFFICELIST OF REFERENCES CITED BY APPLICANT(S)
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2003_1592ASERIAL NO.
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Munenori FUJIMURA et al.FILING DATE
November 19, 2003GROUP
2821

U.S. PATENT DOCUMENTS

*EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
T.D	AA	2002/0033778	3/2002	Yoshinamoto et al.	343	895	
	AB	2003/011532	1/2003	Yoshinamoto et al.	343	895	
	AC	6,163,300	12/2000	Ishikawa et al.	343	702	
T.D	AD	2002/126049 70	9/2002	Okabe et al.	343	700 HS	
	AE						
	AF						
	AG						
	AH						
	AI						

FOREIGN PATENT DOCUMENTS

		DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION YES NO
T.D	AJ	2002-319810 ✓	10/2002	JP			Abstract
T.D	AK	1 239 533 ✓	9/2002	EP			
T.D	AL	0 896 384	2/1999	EP			
	AM						
	AN						

OTHER DOCUMENT(S) (Including Author, Title, Date, Pertinent Pages, Etc.)

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APPLICANT
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November 19, 2003

GROUP 2821

U.S. PATENT DOCUMENTS

*EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
T.D	AA	6,486,853	11/2002	Yoshinamoto et al.	343	895	
	AB	2003/0011532	1/2003	Yoshinamoto et al.	343	895	
	AC	2002/0063658	5/2002	Washiro et al.	343	700MS	
	AD	5,973,651	10/1999	Suesada et al.	343	752	
	AE	5,977,927	11/1999	Mandai et al.	343	788	
	AF	6,064,351	5/2000	Mandai et al.	343	873	
	AG	6,028,554	2/2000	Mandai et al.	343	700MS	
	AH	6,181,001	1/2001	Ikefuji et al.	257	679	
	AI	6,288,680	9/2001	Tsuru et al.	343	702	
	AJ	5,561,430	10/1996	Knebelkamp	343 342	44	
	AK	5,898,413	4/1999	Mandai et al.	343	895	
	AL	5,764,197	6/1998	Tsuru et al.	↓	895	
	AM	5,936,593	8/1999	Mandai et al.	343	895	
	AN	5,949,385	9/1999	Asakura et al.	343	895	
	AO	6,054,956	4/2000	Mandai et al.	343	702	
✓ T.D	AP	5,903,242	5/1999	Tsuru et al.	343	873	

OTHER DOCUMENT(S) (Including Author, Title, Date, Pertinent Pages, Etc.)

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FOREIGN PATENT DOCUMENTS

		DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION YES NO	
T.D	AA	2001-326522	11/2001	JP				
T.D	AB	10-242731	9/1998	JP			Abstract	
T.D	AC	2002-033616	1/2002	JP			Abstract	
T.D	AD	2002-124812	4/2002	JP				
T.D	AE	10-247806	9/1998	JP			Abstract	
T.D	AF	2003-163521	6/2003	JP			Abstract	
T.D	AG	10-200438	7/1998	JP			Abstract	
T.D	AH	11-004117	1/1999	JP			Abstract	
T.D	AI	05-013291	1/1993	JP			Abstract	
T.D	AJ	8-296354	11/1996	JP				
T.D	AK	9-64627	3/1997	JP				
T.D	AL	9-69715	3/1997	JP				
T.D	AM	9-74309	3/1997	JP				
T.D	AN	9-223908	8/1997	JP				
T.D	AO	9-232828	9/1997	JP				
T.D	AP	10-065432	3/1998	JP			Abstract	
T.D	AQ	3011075	12/1999	JP				

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